

Notice of References Cited

Application/Control No.

10/784,782

Applicant(s)/Patent Under
Reexamination
HAN ET AL.

Examiner

Stephen G. Sherman

Art Unit

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,009,584	03-2006	Kim, Jung Hun	345/60
*	B	US-2003/0222835	12-2003	Yoon et al.	345/60
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 3098586 A1	11-2003	World Intellect	TAE et al.	
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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